

Form PTO-1449 U.S. Department of Commerce Patent and Trademark Office Rev. 7/89		Page 1 of 1	
		Attorney Docket: 01-2627A	Examiner: Unknown
		Serial No. 10/754,952	Filing Date: 01/09/2004
LIST OF PRIOR ART CITED BY APPLICANT		Applicants: Lawrence J. Karas et al.	Group Art: Unknown
		FOR: DESULFURIZATION PROCESS	Date: April 9, 2004

#### U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if appropriate
	AA	6,402,939	06/11/02	Yen et al.	208	196	09/28/00
	AB	6,323,147	11/27/01	Yamamoto et al.	502	64	07/30/99
	AC	6,187,934	02/13/01	Tsuij et al.	549	529	03/23/98
	AD	6,114,552	09/05/00	Han et al.	549	529	09/28/99
	AE	6,011,162	01/04/00	Han et al.	549	529	04/15/98
	AF	5,985,136	11/16/99	Brignac et al.	208	216	06/18/98
	AG	5,759,945	06/02/98	Carroll et al.	502	242	03/26/97
	AH	4,367,342	01/04/83	Wulff et al.	549	529	05/26/78
	AI	3,816,301	06/11/74	Sorgenti	208	208	06/30/72
	AJ	3,565,793	02/23/71	Herbstman et al.	208	208	12/27/68
	AK						

#### FOREIGN PATENT DOCUMENTS

		Date	Country	Class	Subclass	Translation	
						YES	NO
	AL	0 345 856	05/25/89	EPC			
	AM	0 492 697	12/12/91	EPC			
	AN						
	AO						

#### OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AP	R. Castillo et al., <u>J. Catalysis</u> 161 (1996) 524.
AQ	
AR	

Examiner \_\_\_\_\_ Date Considered \_\_\_\_\_

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO-1449 Rev. 7/89	U.S. Department of Commerce Patent and Trademark Office	Attorney Docket: 01-2627A	Examiner: Unknown
		Serial No. 10/754,952	Filing Date: 01/09/2004
	LIST OF PRIOR ART CITED BY APPLICANT	Applicants: Lawrence J. Karas et al.	Group Art: Unknown
		FOR: DESULFURIZATION PROCESS	Date: April 9, 2004

#### U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If appropriate
CDT	AA	6,402,939	06/11/02	Yen et al.	208	196	09/28/00
	AB	6,323,147	11/27/01	Yamamoto et al.	502	84	07/30/99
	AC	6,187,934	02/13/01	Tsuji et al.	549	529	03/23/98
	AD	6,114,552	09/05/00	Han et al.	549	529	09/28/99
	AE	6,011,162	01/04/00	Han et al.	549	529	04/15/98
	AF	5,985,136	11/16/99	Brignac et al.	208	216	06/18/98
	AG	5,759,945	06/02/98	Carroll et al.	502	242	03/26/97
	AH	4,367,342	01/04/83	Wulff et al.	549	529	05/26/78
	AI	3,816,301	06/11/74	Sorgenl	208	208	06/30/72
CDT	AJ	3,565,793	02/23/71	Herbstman et al.	208	208	12/27/68
	AK						

#### FOREIGN PATENT DOCUMENTS

		Date	Country	Class	Subclass	Translation YES	Translation NO
CDT	AL	0 345 856	05/25/89	EPC			
CDT	AM	0 492 697	12/12/91	EPC			
	AN						
	AO						

#### OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

CDT	AP	R. Castillo et al., <i>J. Catalysis</i> 161 (1996) 524.
	AQ	
	AR	

Examiner	C A	Date Considered	1/07
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			

**Notice of References Cited**Application/Control No.  
10/754,952Applicant(s)/Patent Under  
Reexamination  
KARAS ET AL.Examiner  
Cephia D. ToomerArt Unit  
1714

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-7,144,499	12-2006	Han et al.	208/208R
*	B US-6,368,495	04-2002	Kocal et al.	208/240
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
U		
V		
W		
X		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.